

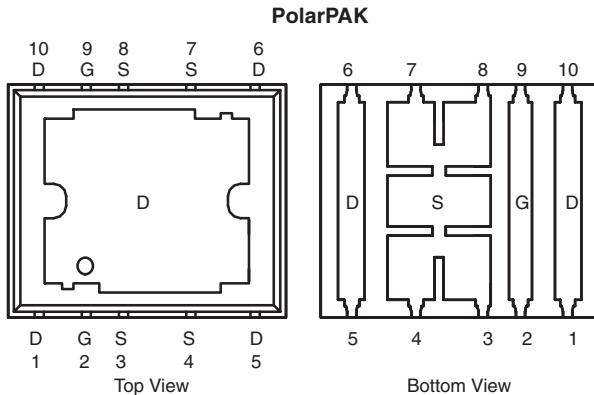


N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^e	Q _g (Typ.)
30	0.007 at V _{GS} = 10 V	44.5	13.1 nC
	0.010 at V _{GS} = 4.5 V	37.3	

Package Drawing

<http://www.vishay.com/doc?72945>



Top surface is connected to pins 1, 5, 6, and 10

Ordering Information: SiE844DF-T1-E3 (Lead (Pb)-free)

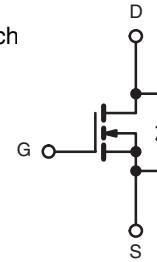
FEATURES

- TrenchFET® Gen II Power MOSFET
- Ultra Low Thermal Resistance Using Top-Exposed PolarPAK® Package for Double-Sided Cooling
- Leadframe-Based New Encapsulated Package
 - Die Not Exposed
 - Same Layout Regardless of Die Size
- Low Q_{gd}/Q_{gs} Ratio Helps Prevent Shoot-Through
- 100 % R_g and UIS Tested



APPLICATIONS

- VRM, POL
- DC/DC Conversion
- Server
- High-Side Switch



N-Channel MOSFET

For Related Documents

<http://www.vishay.com/ppg?69988>

ABSOLUTE MAXIMUM RATINGS T_A = 25 °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	± 20	
Continuous Drain Current (T _J = 150 °C)	I _D	44.5	A
		35.6	
		20.3 ^{a, b}	
		16.3 ^{a, b}	
Pulsed Drain Current	I _{DM}	60	A
Continuous Source-Drain Diode Current	I _S	20.8	
		4.3 ^{a, b}	
Single Pulse Avalanche Current	I _{AS}	25	mJ
Avalanche Energy	E _{AS}	31	
Maximum Power Dissipation	P _D	25	W
		16	
		5.2 ^{a, b}	
		3.3 ^{a, b}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 50 to 150	°C
Soldering Recommendations (Peak Temperature) ^{c, d}		260	

Notes:

a. Surface Mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. See Solder Profile (<http://www.vishay.com/ppg?73257>). The PolarPAK is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

d. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

e. Based on T_C = 25 °C.

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	Steady State	R _{thJA}	20	24	°C/W
Maximum Junction-to-Case (Drain Top)		R _{thJC} (Drain)	4	5	
Maximum Junction-to-Case (Source) ^{a, c}		R _{thJC} (Source)	5.5	7	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. Maximum under Steady State conditions is 68 °C/W.
- c. Measured at source pin (on the side of the package).

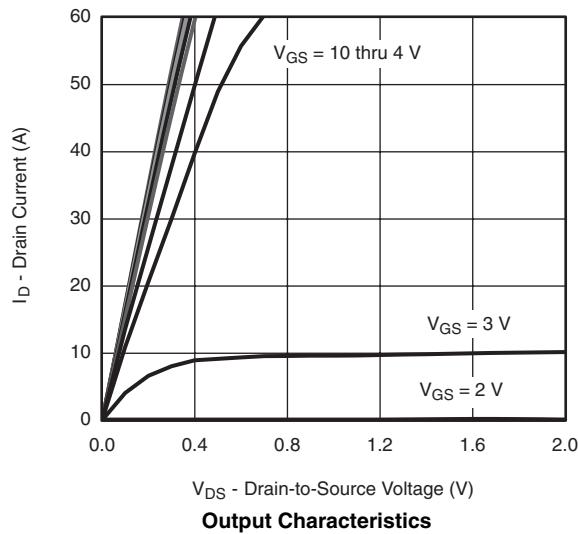
SPECIFICATIONS T_J = 25 °C, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	ΔV _{DS} / T _J	I _D = 250 μA		30		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} / T _J			- 6		
Gate-Source Threshold Voltage	V _{GS(th)}		1		3	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μA
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	25			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 12.1 A		0.0058	0.007	Ω
		V _{GS} = 4.5 V, I _D = 9.7 A		0.0081	0.010	
Forward Transconductance ^a	g _f	V _{DS} = 15 V, I _D = 12.1 A		65		S
Dynamic^b						
Input Capacitance	C _{iss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		2150		pF
Output Capacitance	C _{oss}			320		
Reverse Transfer Capacitance	C _{rss}			120		
Total Gate Charge	Q _g	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 20 A		29	44	nC
Gate-Source Charge	Q _{gs}	V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 20 A		13.1	20	
Gate-Drain Charge	Q _{gd}			6		
Gate Resistance	R _g			3.1		
Turn-On Delay Time	t _{d(on)}	f = 1 MHz V _{DD} = 15 V, R _L = 1.5 Ω I _D ≥ 10 A, V _{GEN} = 4.5 V, R _g = 1 Ω		1.2	1.8	Ω
Rise Time	t _r			25	40	ns
Turn-Off Delay Time	t _{d(off)}			10	15	
Fall Time	t _f			25	40	
Turn-On Delay Time	t _{d(on)}			10	15	ns
Rise Time	t _r			10	15	
Turn-Off Delay Time	t _{d(off)}			25	40	
Fall Time	t _f			10	15	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			20.8	A
Pulse Diode Forward Current ^a	I _{SM}				60	
Body Diode Voltage	V _{SD}	I _S = 10 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C		30	45	ns
Body Diode Reverse Recovery Charge	Q _{rr}			24	36	
Reverse Recovery Fall Time	t _a			16		
Reverse Recovery Rise Time	t _b			14		

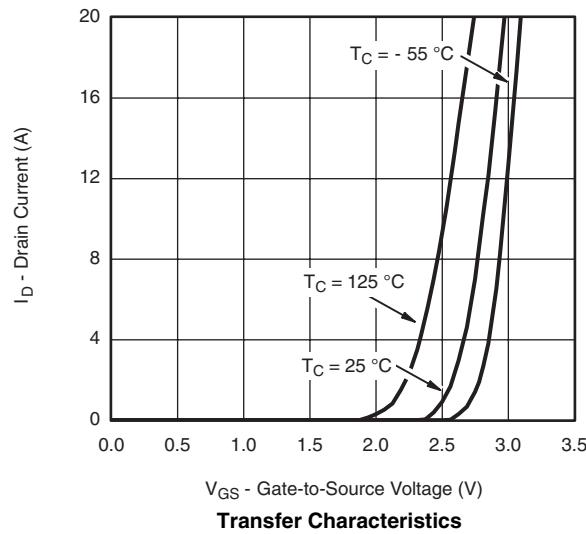
Notes:

- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
- b. Guaranteed by design, not subject to production testing.

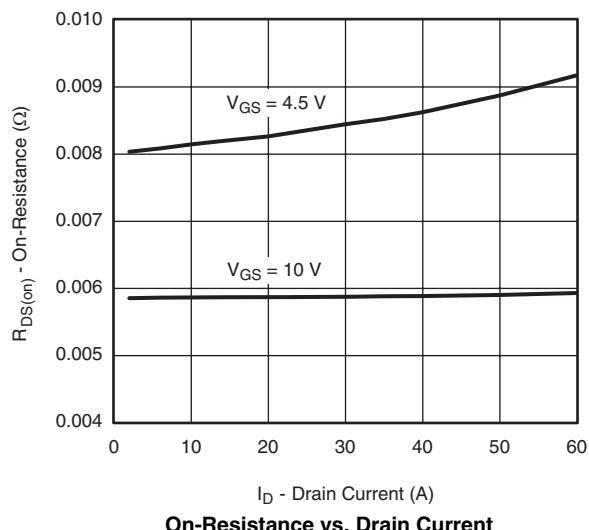
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

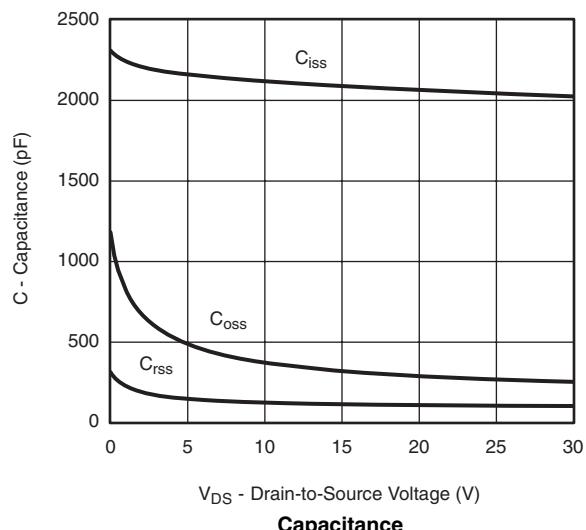
Output Characteristics



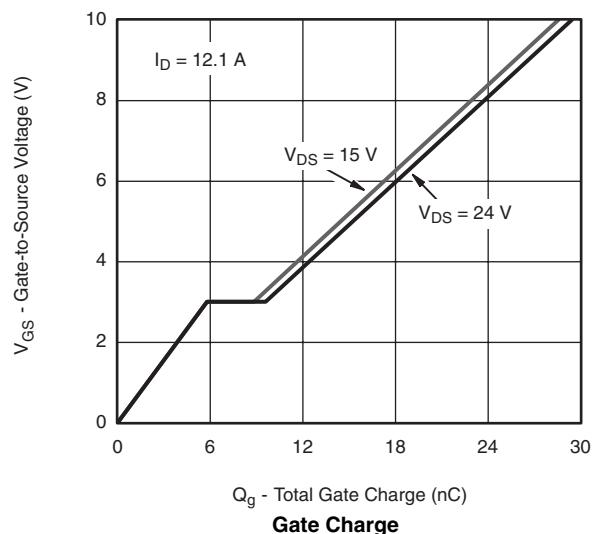
Transfer Characteristics



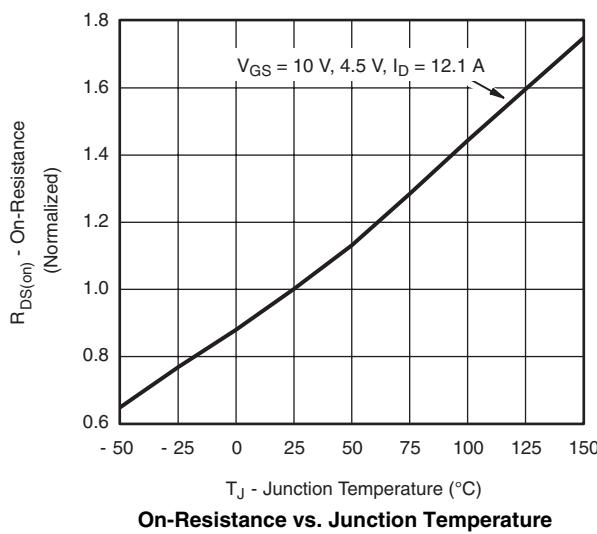
On-Resistance vs. Drain Current



Capacitance



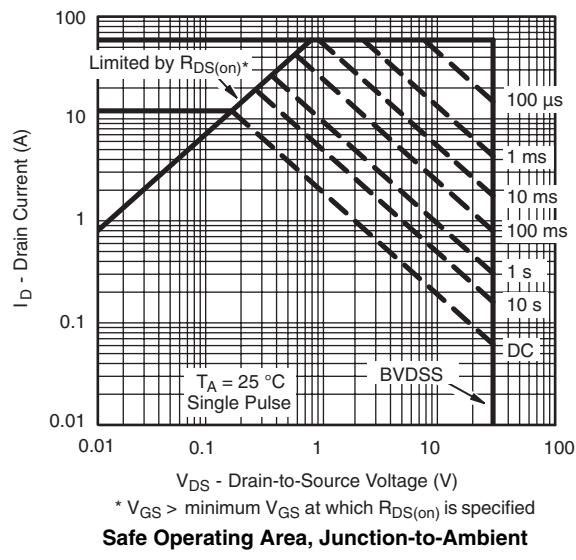
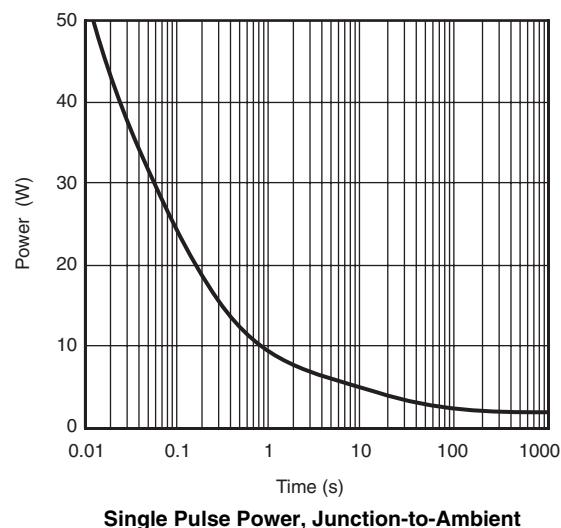
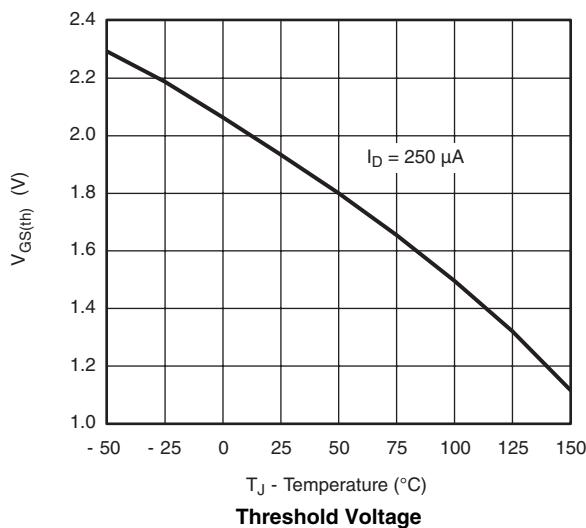
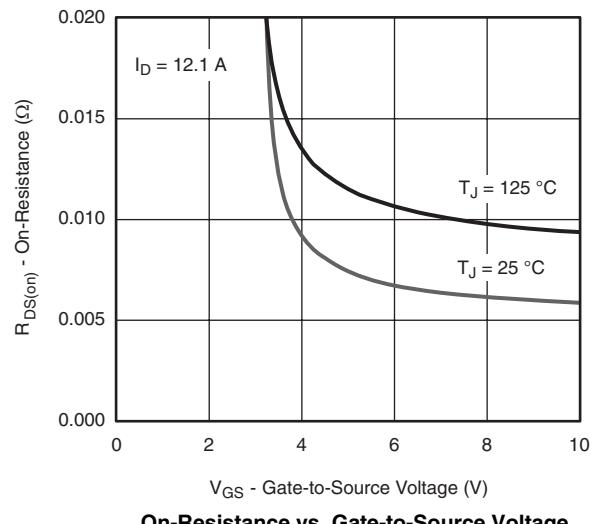
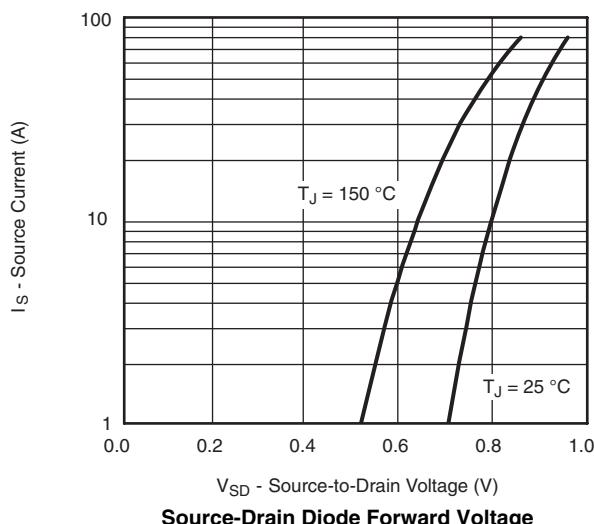
Gate Charge

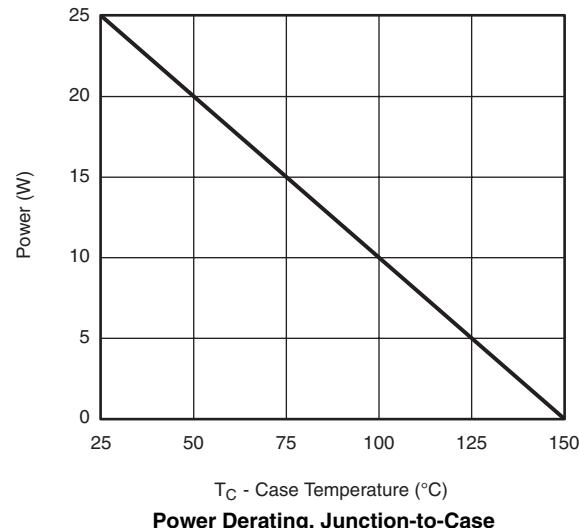
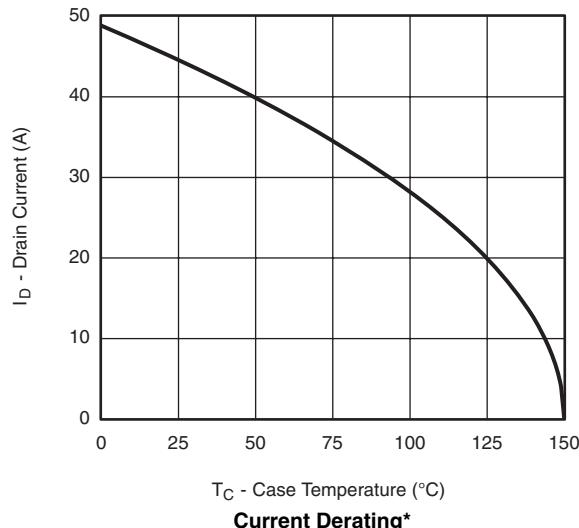


On-Resistance vs. Junction Temperature

SiE844DF

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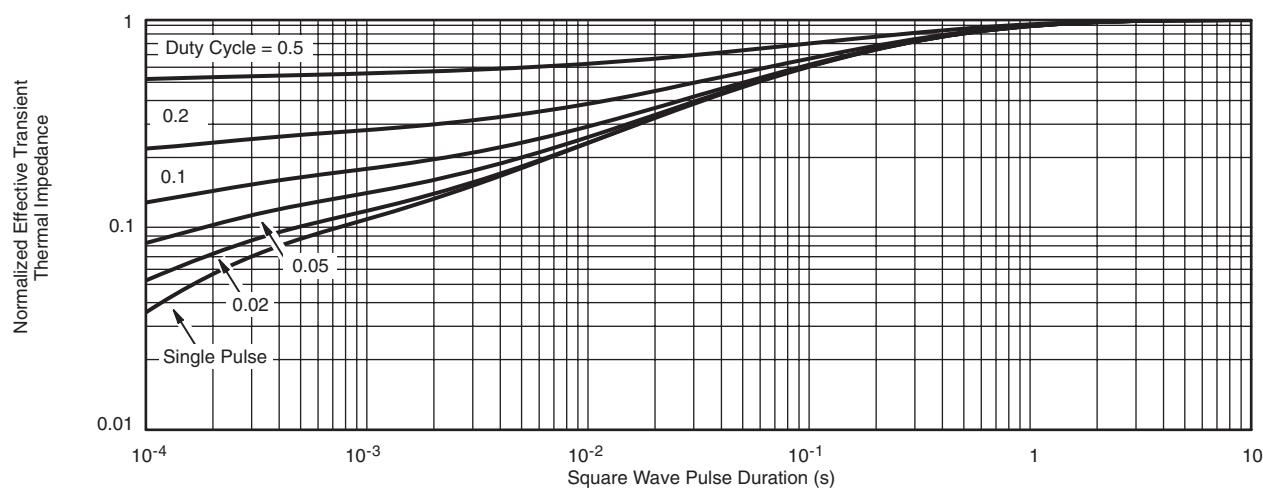
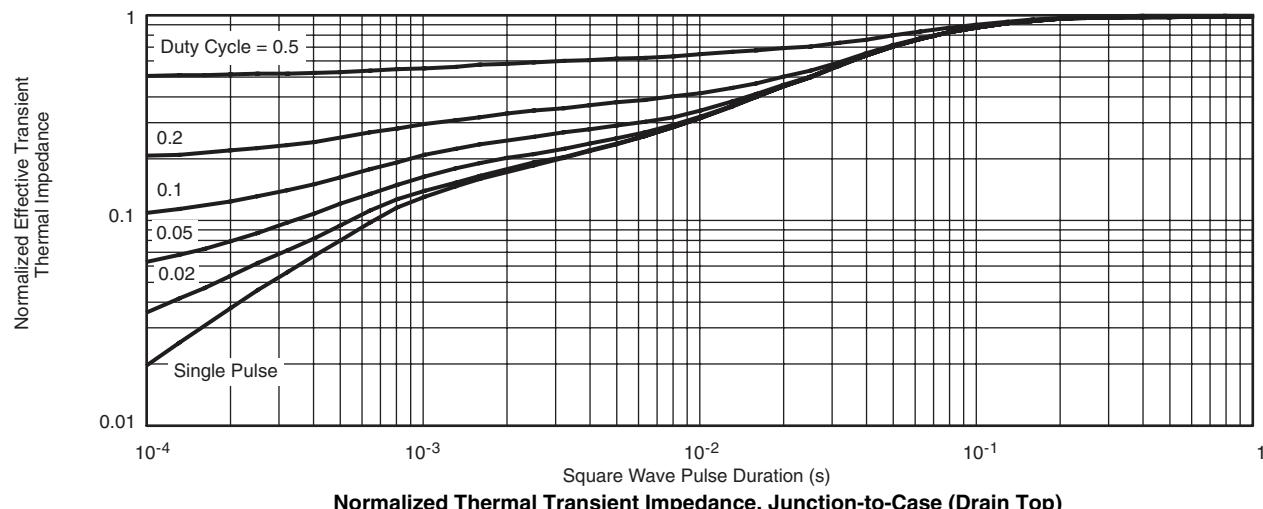
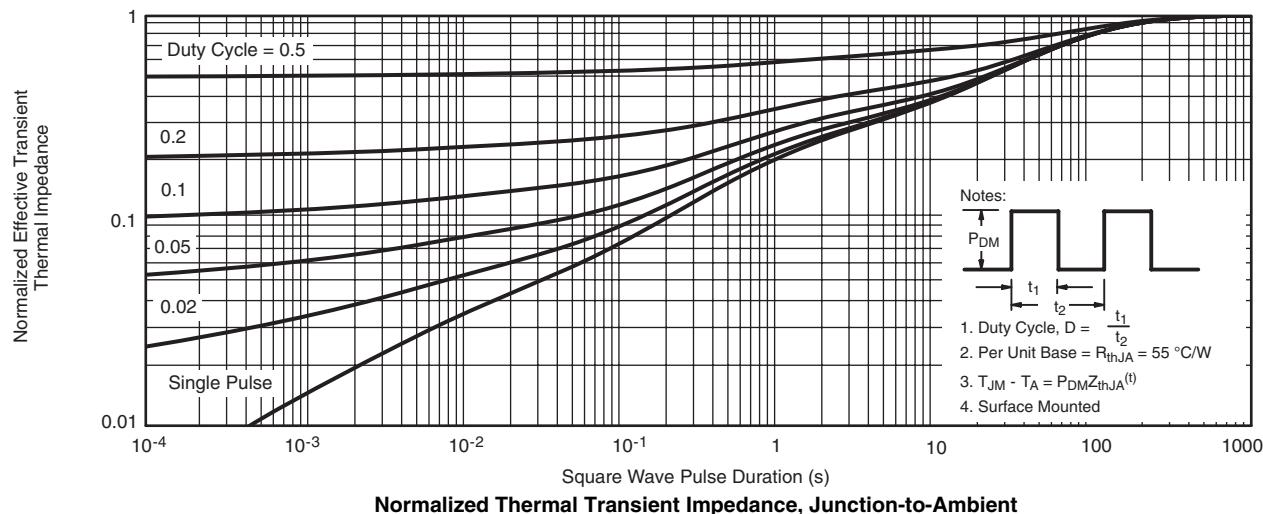
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* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

SiE844DF

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Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <http://www.vishay.com/ppg?69988>.



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